

# AN14010

## Frequency Measurement Module on LPC553x/S3x Devices

Rev. 1 — 23 August 2023

Application note

### Document Information

Information	Content
Keywords	AN14010, FREQME, frequency, duty cycle
Abstract	This document describes how to use and configure the frequency measurement module on LPC553x/S3x devices.



## 1 Introduction

The frequency measurement (FREQME) block has been introduced for LPC553x devices. This simple peripheral block can solve specific software tasks by hardware and save computation power for other application cases. This peripheral block is intended for frequency and pulse width measurement of internal and external signals.

This application note helps the user to understand this module and examples in this application note accelerate the feature evaluation.

## 2 Acronyms

[Table 1](#) lists the acronyms used in this document.

**Table 1. Acronyms**

Acronym	Meaning
FREQME	Frequency measurement
PWM	Pulse width measurement
SDK	Software development kit
MCU	Microcontroller unit
REF_CLK_IN	Reference clock input
TARGET_CLK_IN	Target clock input

## 3 FREQME module

FREQME accurately measures the frequency of an on/off-chip target clock signal using a selectable on-chip reference clock. For example, it accurately determines the frequency of a low-power oscillator that varies depending on process and temperature.

The features of the FREQME module are as follows:

- High-accuracy frequency measurement mode for on-chip and off-chip clocks
- Pulse width measurement (PWM) mode
- Reference and target clock inputs, selectable from among various chip-specific options
- Optional measurement complete interrupt
- Result of out-of-range detection with optional interrupt



**Figure 1. FREQME block**

## 4 Configuration of register

FREQME is a basic module with five registers. The main register to configure is `CTRL_W`. Users can use the software development kit (SDK) driver or directly write to registers using predefined masks from the device header file. If there is required manual clearing of status flags without the SDK driver, then the user has to read

the `FREQMCTRLSTAT` register first, then clear the required bits (for example, `MEASURE_IN_PROGRESS_MASK`, `LT_MIN_STAT`, `GT_MAX_STAT`), and write back to the `CTRL_W` register.

Examples for evaluation are created using the SDK driver. There is only one non-SDK function for setting up the reference scale at runtime.

## 4.1 Frequency measurement mode

In frequency measurement mode, the SDK configuration is set as shown in [Equation 1](#):

$$\text{config.operateMode} = kFREQME\_FreqMeasurementMode \quad (1)$$

For this mode, `FREQME` counts the number of target clock cycles that occur during a specified number of cycles from a reference clock with a known frequency.

Calculation of target frequency is based on [Equation 2](#):

$$F_{target} = (CTRL\_R[RESULT] - 2) \times \text{Reference} \div 2^{CTRLSTAT[REFSCALE]} \quad (2)$$

The [Equation 2](#) is implemented in the SDK function `FREQME_CalculateTargetClkFreq`, which is used in the software example. 12 MHz oscillator is selected as reference clock and the main system clock is selected as target clock. By setting a higher reference scale number, the target frequency is measured for longer time to get higher and more precise result.

The SDK functions `FREQME_SetMinExpectedValue` and `FREQME_SetMaxExpectedValue` are used to configure the minimum and maximum registers. `FREQME` module trigger interrupt or set flag when the result register is out of predefined limits. For example, the flag must be checked in some periodic event or the background loop. In the example, an interrupt-based approach is used. For starting the measurement cycle, the SDK function `FREQME_StartMeasurementCycle` is used and it is used each time after getting the result. In the default configuration, the example must work after build.

## 4.2 Pulse width measurement mode

The SDK configuration sets the pulse width mode as shown in [Equation 3](#):

$$\text{config.operateMode} = kFREQME\_PulseWidthMeasurementMode \quad (3)$$

For this mode, the reference scale parameter is ignored. `FREQME` module counts reference clock pulses while the target clock is in a specific state (high or low). Polarity of the measured signal can be changed in runtime using the `FREQME_SetPulsePolarity` function.

In the example, the `eFlexPWM` module is used as a reference clock. Pulse width can be set from the `FreeMASTER`. This signal must be externally routed to the specific GPIO pin. Main system clock is internally routed as the target clock of `FREQME` input.

## 5 Evaluation of the examples

For project evaluation, install the latest [MCUXpresso IDE](#) and [FreeMASTER](#) real-time debugger. Although some familiarity with `FreeMASTER` debugging is helpful, this project is so simple that even beginners must not encounter any difficulties.

In the example, define `FREQ_MEAS`, which switches the code between frequency or pulse width measurement.

For pulse width measurement, connect wire from PWM output pin to `FREQME` input pin as it is platform-dependent, see [Table 2](#). For frequency measurement, wire connection is not required as everything is done internally.

Table 2. Hardware signals on the EVK

EVK board	Header	MCU port	MCU signal
LPCXpresso55S36	J10-15	1-20	PWM0 A0
LPCXpresso55S36	J10-5	1-4	FREQME CLKA

To import the project into the IDE, perform the steps as follows:

1. Open `main.c` source file and set `#define FREQ_MEAS` for required operation:
  - 1 for frequency measurement
  - 0 for pulse width measurement
2. Build and flash the project.
3. Start FreeMASTER and load `FREQMEASURE_evaluation.pmpx` project.
4. To run FreeMASTER communication, click the GO button.
5. Watch and set variables and observe the FreeMASTER scope.

[Table 3](#) explains the variables used in the project. Read/write (R/W) attribute means that it is accessible from FreeMASTER.

Table 3. Variables

Variable	Description	R/W
<code>ui8PulsePol</code>	Pulse polarity <code>kFREQME_PulseLowPeriod</code> or <code>kFREQME_PulseHighPeriod</code> for pulse width measurement mode.	RW
<code>ui32FreqmeResultReg</code>	Raw measurement result	R
<code>ui32MeasFreq</code>	Calculated frequency	R
<code>ui32RefFreq</code>	Reference frequency	R
<code>ui32FreqMeasLoLim</code>	Minimum register value	RW
<code>ui32FreqMeasHiLim</code>	Maximum register value	RW
<code>ui32RefScale</code>	Scale for frequency measurement. If a higher number is set, more time is required to collect the result. In extreme cases, it takes up to minutes.	RW
<code>il6Duty</code>	PWM duty cycle source for pulse width measurement	RW
<code>ui32ResultOverflowCnt</code>	Incrementing number when overflow occurs	R
<code>ui32ResultUnderflowCnt</code>	Incrementing number when underflow occurs	R
<code>ui32ResultReadyCnt</code>	Incrementing number when the result is ready	R

## 5.1 Troubleshooting


The examples function in the default configuration; however, some behavior can occur, especially when editing the project. The main pointer that the application runs OK is that the numbers in FreeMASTER are live, especially `ui32ResultReadyCnt` must increment.

[Table 4](#) lists the issues and provides the solution when the application is not working correctly.

Table 4. Troubleshooting

Issue	Solution
<code>ui32ResultReadyCnt</code> has no increment	In pulse width measurement mode, the wire is not connected on the EVK board from PWM output pin to FREQME input pin.

Table 4. Troubleshooting...continued

Issue	Solution
ui32ResultReadyCnt has no increment	Input mux to the FREQME module are not correct or source signals (clocks) are not enabled in the system.
ui32ResultReadyCnt has no increment	Scale set close to its limits (31) produces long waiting time until the results are ready (up to minutes). Use lower scale if you want to get the results faster.
ui32MeasFreq is 0	For pulse width mode, frequency calculation does not make sense so the result is 0 because ui32RefFreq is preset to 0. In frequency measurement mode, check why ui32RefFreq is not filled with reference clock value.
FreeMASTER cannot connect to the target	A debug session running in the MCUXpresso IDE is the most usual behavior. User must kill the debug session in the MCUXpresso IDE. It is not possible to run both debug sessions (MCUXpresso and FreeMASTER) because they access the same debug interface. It is recommended not to use the debug session for flashing instead use the flash button  . To enable the flash button in the menu bar, perform the following steps: <ol style="list-style-type: none"> <li>1. User must select the project. <b>Note:</b> User must select the project again as sometimes after the build, the project is unselected.</li> <li>2. User must kill the debug session in MCUXpresso when the conflict occurs with the debug and FreeMASTER session.</li> <li>3. Unplug/plug EVK USB and restart FreeMASTER.</li> <li>4. User must click the GO button to start communication.</li> </ol>

## 6 References

Table 5 lists the resources that can be referred for more information.

Table 5. References

Documents/resources	Link/how to access
MCUXpresso Integrated Development Environment	<a href="#">MCUXpresso IDE</a>
FreeMASTER Run-Time Debugging Tool	<a href="#">FreeMASTER</a>

## 7 Revision history

Table 6 summarizes the revisions to this document.

Table 6. Revision history

Revision number	Release date	Description
1	23 August 2023	Initial public release

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